

The model CPS-100-CF-77K enables cost effective, stable, reliable and convenient probing of devices and circuits at very low temperatures. Built-in vibration isolation, smart thermal management, and engineered thermal expansion compensation makes this system ideally suited for a wide range of applications spanning from nanoelectronics (graphene research, molecular electronics, etc.) to space based electronics. The system uses closed-cycle refrigerator and proprietary thermal management permitting inexpensive and fast operations. Built-in vibration isolation minimizes the vibrations to industry-standard levels. Ultra-stable micro-manipulated stages permit accurate and reproducible contact of the probe tip on device features. Wide selection of the probes and wafer chucks permit applications ranging from ultraprecise, fA-scale measurements, RF measurements and many more.

Key Features

- Cost- effective, stable, reliable, and convenient to use for up to 100mm diameter wafers
- Temperature range from 4.5K to 480K (0.1K accuracy)
- Closed- cycle refrigerator for cost effective cryogen-free operations
- Characterization of up to 2" diameter sample
- DC to 67GHz measurements with proper probes selected
- 4 micromanipulated probe arms (up to 8 available in optional configurations), with highly accurate XYZ and optionally θ adjustment, with up to 4" X, 134" Y and 0.5"Z
- Thermally anchored probe tips
- Temperature- controlled radiation shield
- Clear view top window (high purity quartz)
- High frequency vibration damping
- High level of customization to accommodate most exotic probing needs





ecifications :	
Chuck size	
	 Up to 25mm, 50mm or 100mm
Thermal specifications	
	 Cryogen-free closed cycle refrigerator including colo
	head, compressor, chiller and required helium hose
	 Temperature range: below 77K to 480K and mor are available
	- Temperature accuracy: 0.1K
	 Temperature stability: ±50 mK below 100K
	- Temperature resolution: 0.001K
	 Thermally anchored probe arms and radiation shiel
	 Temperature controlled (heater) chuck
	 Temperature monitoring of the chuck and probe are
	Temperature monitoring of radiation shield is optio
Vacuum	
	- Base pressure 1.0×10^{-5} torr standard with proper
	vacuum pump selected, down to sub-10 ⁻⁶ torr option
	- Gas port and pressure relief valve are included in b
	system
Optics	
	- Additional viewports: can be added by customer
	request
	- Window materials : fused silica, custom materials
Migue	and coatings are available
Microscope:	- Oientig's Ontom Zoom 70 system (Aum resolution)
	- Qioptiq's Optem Zoom 70 system (4um resolution)
	standard, Zoom 125 or zoom 160 system are
	available as options, as well as less expensive solutions
	- Coaxial and ring light LED illumination
	- Optional cooled shutter
	- Either boom mounted or with base mounted on fin
	resolution XY or XYZ slieds
	resolution AT of ATZ sileus
Cameras:	
333.	- Digital cameras ranging from 1 megapixel to 10
	megapixels. Included with the camera is software
	image and video capture as well as dimension
	-
	measurement capability

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Specifications (cont.):

Probes

- DC (coaxial or triaxial)
- RF (various)

Micromanipulators

- Various resolutions (40TPI or $3\mu m$ is standard, better resolution is available with extra cost) and ranges (2"x1"x0.5", 4"x1"x0.5" or 4"x1.75' x 0.5")available

Cables available

- Cryogenic temperature- compatible coaxial cables
- Cryogenic temperature-compatible triaxial cable

Wafer chucks available

- Grounded
- Isolated
- Coaxial
- Triaxial

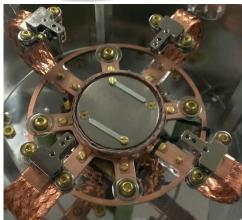
Software

 LabView-based software for computer control and monitoring of temperatures. Several temperature testing sequences are pre-programmed and custom sequences can be easily programmed by the end user

Vibration isolation

- Vibration isolation table with air damping system
- Vibration- isolating bellows
- Vibrations at the chuck <1μm







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